

Search Notes

Application/Control No.

10/653,974

Examiner

Richard Chan

Applicant(s)/Patent under
Reexamination

MIYAMURA, JUN

Art Unit

2685

SEARCHED

Class	Subclass	Date	Examiner
455	150.1	12/12/2005	RC
455	161.1	12/12/2005	RC
455	161.2	12/12/2005	RC
455	161.3	12/12/2005	RC
455	179.1	12/12/2005	RC
455	180.1	12/12/2005	R
455	183.2	12/12/2005	RC
455	186.1	12/12/2005	RC
455	185.1	12/12/2005	RC
455	168.1	12/12/2005	RC
455	184.1	12/12/2005	RC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted Quochien Vong	12/12/2005	RC
Consulted Edward Urban	12/13/2005	RC